## **SpotOptics**

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# **OMI-SWIR**



## FAST & ACCURATE WAVEFRONT SENSOR

- Acquisition speed up to 300 Hz, analysis speed up to 200Hz
- Optimized for SWIR wavelength range with InGaAs camera
- Accurate metrology in single pass (OMI) and double pass (Optino)
- Optical elements, lasers and laser diodes
- Test any focal length and diameter (with accessories)
- Large dynamic range
- High sampling
- Adaptable for production





### **TECHNICAL SPECIFICATIONS**

Hardware			
Test	Optical elements, lasers and laser diodes		
Power of laser diode that can be tested	Few mW. Higher powers require reduction system (available)		
No of spots (see cameras below)	35x35 (standard camera), 60x60 (large format camera)		
Diameter and focal length of standard lenslets	(φ=0.2mm,f=11mm),(φ=0.15mm,f=7mm)		
Software			
Software (control and analysis)	Sensoft for 64bit Win7, Win 8.1, Win 10		
RMS repeatability of Zernike coefficients	<2nm rms (λ/800 @ 1550nm)		
RMS repeatability of modal wavefront measurements	<λ/100		
Accuracy and dynamic range	$\lambda/20$ - $\lambda/100$ (calibration dependent), -±50 $\lambda$		
Camera (see next page for details)			
etector, wavelength range and cooling InGaAs. 0.90μ -1.7μ, Uncooled or Peltier cooled version			
Connection, bits	Gigabit Ethernet, 12-bits or 14-bits		
Acquisition speed	From 100Hz up to 340Hz at full resolution. Speeds up to 1700Hz available with custom cameras		
Triggering	Yes		
Exposure time range	5ums-100msec (uncooled), 5ums-1s (cooled)		
Accessories			
Light sources, beam expanders and compressors	High quality LD at test wavelength, beam expanders/compressors		

## OMI models: cooled and uncooled. High acquisition and computational speed

## **Standard resolution**

Resolution : 35x35 spots

Chip size: 9.6x7.68 mm<sup>2</sup>

Pixel size: 30 μ

High acquisition speed: up to 344fps

High computation speed: up to 200Hz

InGaAs detector for high accuracy

Wavelength range: 0.9-1.7 (µ)

**Giga Ethernet connection** 

### **High resolution**

Resolution : 60x60 spots

Chip size: 15.9x12.7 mm<sup>2</sup>

Pixel size: 25 µ

High acquisition speed: up to 301fps

High computation speed: up to 100Hz

InGaAs detector for high accuracy

Wavelength range: 0.9-1.7 (µ)

Giga Ethernet connection

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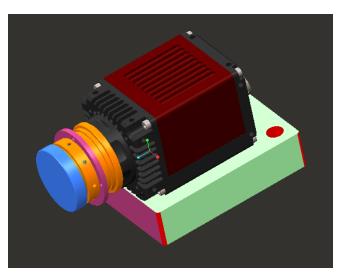
## OMI models details (standard resolution models)

Model of wavefront sensor	OMI-SWIR-HS-340	OMI-SWIR-118	
Highlights	High-speed, Uncooled, 344fps	High-speed, Uncooled, 344fps Uncooled, 118fps	
Peltier cooling	No. Temperature stabilized TEC1	No. Temperature stabilized TEC1	Yes
Output(bits)	14	12	12
Operating temp (°C)	Minimum +10	Minimum +10	-20 to +55 (case)
Power requirement (V DC)	10.8-30 or via PoE	12	12
Power consumption (W)	10.8 (@ 12V DC)-12.5W (@ PoE)	7.2	33.6
Weight (Camera+OMI) (g)	340+50=390	660+50=710	1420+50=1470
Dimension (L,W,H in mm)	78x55x55	80x90x71	116x90x99
Acquisition speed (fps)	344	118	118
Analysis speed for Zernike	~200	~100	~100
coefficients in loop mode( Hz)			

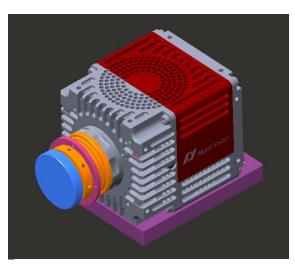
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## OMI models details (high resolution models)

Model of wavefront sensor	OMI-SWIR-100-HR	OMI-SWIR-301-HR-HS	OMI-SWIR-100-HR-C	OMI-SWIR-30-HR
Highlights	High-resolution,	High-resolution, Uncooled,	High resolution, Cooled,	High resolution, Cooled,
	Uncooled, 100fps	301fps	100fps	30fps
Peltier cooling	No. Temperature	No. Temperature	Yes. TEC2	Yes. TEC2
	stabilized TEC1	stabilized TEC1		
Output(bits)	14	14	14	12
Operating temp (°C)	Minimum +10	Minimum +10	-20 to +55 (case)	-20 to +55 (case)
Power requirement (V DC)	10.8-30 or via PoE	10.8-30 or via PoE	or via PoE	12V
Power consumption (W)	10.8W(@12VDC)-	10.8W(@12VDC)-	19W(@12VDC)-	15.6
	12.95W(PoE)	12.95W(PoE)	22W(PoE)	
Weight (Camera+OMI) (g)	370+50=420	370+50=420	810+50=860	1110+50=1160
Dimension (L,W,H in mm)	78x55x55	78x55x55	90×80×80	116x90x99
Acquisition speed (fps)	100	301	100	30
Analysis speed for Zernike	~50	~100	~50	~30
coefficients in loop mode( Hz)				



OMI-SWIR-HS-340 and OMI-SWIR-100-HR

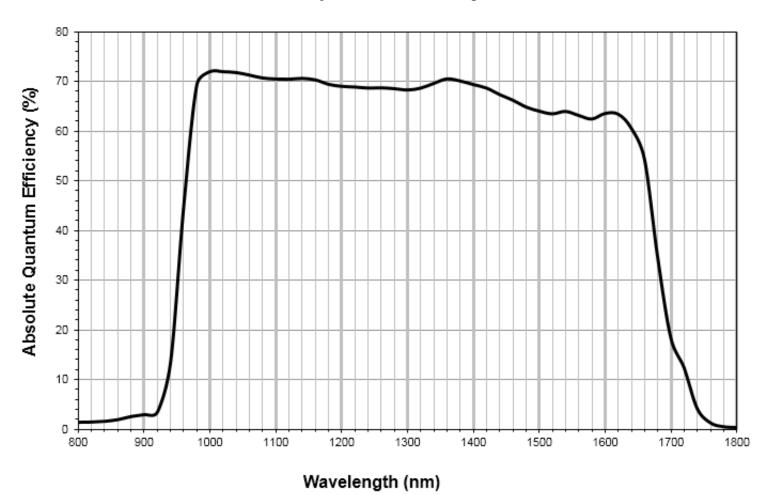


OMI-SWIR-100-HR-C HR



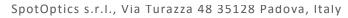
OMI-SWIR118(C) and OMI-SWIR-30-HR

## Quantum efficiency curve of InGaAs sensor



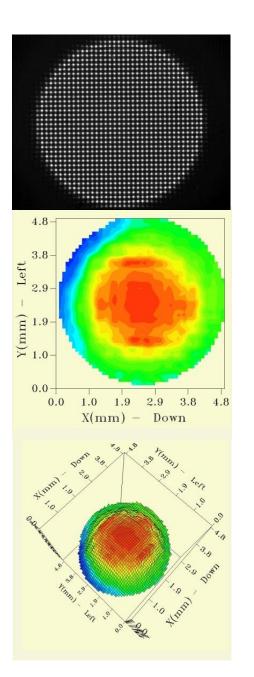
Spectral sensitivity

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## SENSOFT: THE SOFTWARE

#### Sensoft: The modular software package

- Fully controls the hardware of OMI
- Performs the Shack-Hartmann (SH) analysis
- Computes Zernike coefficients, diagnostics (alignment and correct focal plane), wavefront, MTF, spot diagram
- Has a Loop mode for on-line adjustment of optical systems

#### **OMI in your production line:**

- OMI with its own PC can easily be adapted to the production line
- It can work in a closed-loop with the PC of the manufacturing machine
- A software module defines the IP communication protocol and transfers the results between the PCs in the Local Area Network

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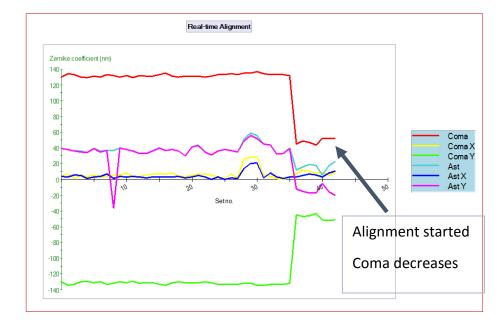
## ON-LINE ALIGNMENT IN A FAST LOOP

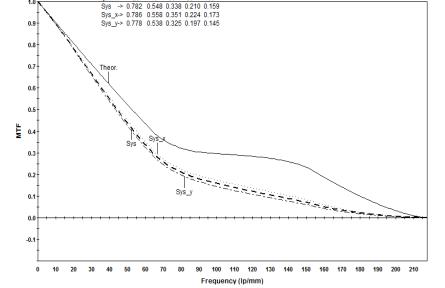


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40 60

80 100





- The alignment of complex optical systems becomes easy by monitoring coma and astigmatism in a continuous loop
- The individual (x, y) components of coma and astigmatism, as well as the total coefficients are displayed
- The optimization can be done for one component at a time, as the software can display one component of interest

## MTF after subtracting the contributions of tilt and defocus present in the data.

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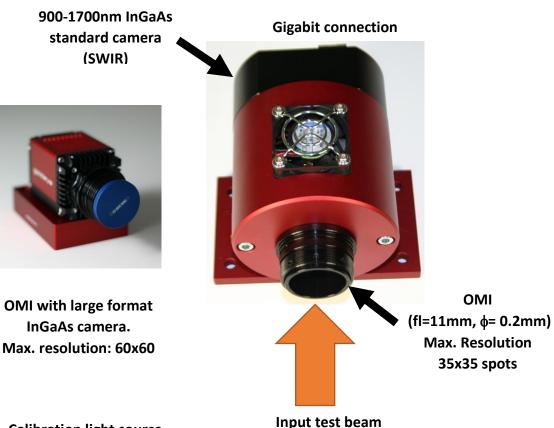
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## **OMI** with CAMFRA



**Calibration light source** (parallel or pinhole): LD at different SWIR wavelengths available

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#### PHYSICAL

#### **Dimensions**

 $\sim$ 89 (L) x 90 (W) x 71(H) mm (with standard camera)  $\sim$ 90 (L) x 80 (W) x 80(H) mm (with large format camera) Weight ~400g-1500g

**Cameras** InGaAs, Gigabit Ethernet connection, 12-14bit

### **KEY FEATURES**

#### **Measurement technique**

Shack-Hartmann wavefront sensor

#### Test in parallel light or at the lens focus

Parallel light (with a calibration unit) At the focus of the lens (with pinhole calibration unit)

Light sources with different wavelength available

#### **Calibration units available**

High-quality parallel light source (motorized or manual) Pinhole calibration unit

#### Versatile

OMI

Max. Resolution

35x35 spots

Test any optical element and lasers in single pass

#### Accessories

Full set of accessories available (e.g. light sources)

#### SOFTWARF

- Easy alignment of lens group via software: the • software gives graphical indication of the misalignment of the optical system, using coma and astigmatism.
- Stabilization of lasers: the software gives graphical indication of focusing of the laser beam